# Q.raxx A106 Measurement Module for Strain Gage and LVDT/RVDT



Q.raxx is the ideal 19" rackmount DAQ solution for applications that require high channel density. Q.raxx DAQ systems can utilize an integrated, high-performance controller for communication, control, and data logging purposes. With a controller, multiple Q.raxx systems can be synchronized to each other allowing for efficient DAQ distribution with low jitter and gradual expansion up to thousands of channels.

- High Density up to 13 I/O modules per Q.raxx 3U chassis with up to 16 channels per I/O module
- User Friendly front panel indicators for module status, power, and input range error
- Fully Customizable multiple front panel termination options available
- Maximum Flexibility parallel communication available in TCP/IP, CAN, PROFIBUS, Modbus, and EtherCAT



# **Key Features**

- 2 galvanically isolated analog inputs channels strain gage and inductive half and full bridges, LVDT, RVDT quarter bridge with completion terminal
- DC and carrier frequency (CF) principle
  2.5 and 5 VDC excitation, 2.5 and 5 VDCeff excitation carrier frequency,
  600 Hz or 4.8 kHz configurable per channel
- 2 Analog output channels
  ±10 VDC, 10 kHz update rate per channel
- High-accuracy digitization
  24-bit ADC, 10 kHz sample rate per channel
- 4 digital I/Os input: state, tare, memory reset, output: state, alarm, threshold
- Signal conditioning linearization, filtering, average, scaling, min/max, RMS, arithmetic, alarm
- 3-Way galvanic isolation
  500 VDC channel to channel, channel to power supply, and channel to bus



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# Measurement Module for Strain Gage and LVDT/RVDT

# Block diagram



# **Technical Data**

### Analog Input

Channels	2	
Accuracy	0.02 % typical	
	0.05 % in controlled environment <sup>1</sup>	
	0.1 % in industrial area <sup>2</sup>	
Linearity error	0.02 % typical full-scale	
Repeatability	0.01 % typical (within 24 hrs)	
Input impedance	>10 MΩ	
Isolation voltage	500 VDC channel to channel, to power supply, channel to bus <sup>3</sup>	

 $^{\rm 1}\,$  according to EN 61326 2006: appendix B

<sup>2</sup> according to EN 61326 2006: appendix A

<sup>3</sup> noise pulses up to 1000 VDC, continuous up to 250 VDC

## Analog to Digital Conversion

Resolution	24-bit
Sample rate	10 kHz per channel
Modulation method	sigma-delta
Anti-aliasing filter	2 kHz, 3rd order (DC excitation) 1 kHz, 3rd order (4.8 kHz CF excitation) 100 Hz, 3rd order (600 Hz CF excitation)
Digital filters	Infinite impulse response (IIR), low-pass, high-pass, band-pass, band-stop, to 8th order Butterworth or Bessel, frequency range 0.1 Hz to 1 kHz in steps of 0.1 (adjustable via software)
Averaging	configurable or automatic according to the user-defined data rate



# Measurement Module for Strain Gage and LVDT/RVDT

# Analog Output

Channels	2	
Accuracy	0.02 % typical	
Voltage output	±10 VDC	
Allowable load resistance	>2 kΩ	
Long-term drift	<1 mV / 24 hrs	< 2.5 mV / 8000 hrs
Temperature drift	<1 mV /10 K Offset drift	< 0.05 % / 10 K Gain drift
Noise voltage	< 2 mV at 10 Hz	<10 mV at 1 kHz

# Digital Input & Output

Channels	4 configurable I/Os
Mode(s) of operation	status
Logic voltage	<2 VDC (Low) >10 VDC (High)
Input type	PNP (current sinking)
Input voltage	30 VDC max.
Output voltage	10 to 30 VDC (external supply required)
Contact	open drain p-channel MOSFET
Load capacity	30 VDC / 100 mA (ohmic load)

### Strain Gage Measurement

Bridge configuration(s)	resistive full-bridge (4/6-wire) resistive half-bridge (3/5-wire) resistive quarter-bridge 120 Ω or 350 Ω (3-wire, with bridge completion terminal)			
Allowable sensor cable length	< 300 m (DC and 600 Hz ( <100 m <sup>1</sup> (4.8 kHz CF exc	< 300 m (DC and 600 Hz CF excitation) <100 m <sup>1</sup> (4.8 kHz CF excitation)		
Shunt resistor	100 kΩ internal resistor			
Bridge excitation	2.5 - 5 VDC 2.5 - 5 Veff (Carrier Frequ	iency)		
Bridge excitation stability	<0.01% / 24 hrs			
Bridge excitation drift	<0.02%/10K			
	5 VDC	5 Veff (CF)	2.5 VDC	2.5 Veff (CF)
Allowable sensor resistance	> 300 Q	> 300 Ω	>100 Q	>100 Q
Input range	±1.25 mV/V	±1.25 mV/V	±2.5 mV/V	±2.5 mV/V
	±2.5 mV/V	±2.5 mV/V	±5 mV/V	±5 mV/V
	±25 mV/V	±25 mV/V	±50 mV/V	±50 mV/V
	±50 mV/V	±50 mV/V	±100 mV/V	±100 mV/V
	±100 mV/V	±100 mV/V	±200 mV/V	±200 mV/V
	±200 mV/V	±200 mV/V	±400 mV/V	±400 mV/V
	±500 mV/V	±500 mV/V	±1000 mV/V	±1000 mV/V
Long-term stability	<0.2 µV/V / 24 hrs (DC excitation) <0.1 µV/V / 24 hrs (CF excitation)		<2 µV/V / 8000 hrs (DC e <1 µV/V / 8000 hrs (CF e	excitation) xcitation)
Temperature drift (range 2.5 mV/V)	< 0.2 µV/V / 10 K Offset o	Irift	< 0.05 % / 10 K Gain drift	
Signal-to-noise ratio	< 0.3 µV/V at 10 Hz		<1 µV/V at 100 Hz	

 $^{\rm 1}\,$  low capacity sensor cable is strongly recommended

# Measurement Module for Strain Gage and LVDT/RVDT



## LVDT/RVDT Measurement

Sensor connection	4-/6-wire	
Sensor excitation (selectable)	5 Veff	2.5 Veff
Allowable sensor resistance	>300 Ω	>100 Q
Input range	±1.25 mV/V	±2.5 mV/V
	±2.5 mV/V	±5 mV/V
	±25 mV/V	±50 mV/V
	±50 mV/V	±100 mV/V
	±100 mV/V	±200 mV/V
	±200 mV/V	±400 mV/V
	±500 mV/V	±1000 mV/V
Allowable sensor cable length	<100 m <sup>1</sup>	
Long-term stability	<0.1 µV/V / 24 hrs	<1 µV/V / 8000 hrs
Temperature drift (range 2.5 mV/V)	<0.2 µV/V / 10 K Offset drift	< 0.05 % / 10 K Gain drift
Signal-to-noise ratio	< 0.3 µV/V at 10 Hz	<1 µV/V at 100 Hz

<sup>1</sup> low capacity sensor cable is strongly recommended

# Digital to Analog Conversion

Resolution	16-bit
Update rate	10 kHz per channel
Settling time	Shi

## Communication Interface

Protocols	proprietary Localbus (115200 bps to 24 Mbps, latency <100 ns)
	ASCII (19200 bps to 115200 bps)
	Modbus RTU
	Profibus-DP (19200 bps to 12 Mbps) (special Firmware required)
Data format	8E1
Electrical standard	ANSI/TIA/EIA-485-A, 2-wire

## Power Supply

Input voltage	10 to 30 VDC, overvoltage and overcurrent protection
Power consumption	2.5 W (approx.)
Input voltage influence	<0.001 % / V

## **Environmental Specifications**

Electromagnetic compatibility (EMC)	according to IEC 61000-4 and EN 55011	
Operating temperature	-20°C to +60°C	
Storage temperature	-40°C to +85°C	
Relative humidity	5 - 95 % at 50°C (non-condensing)	

# Measurement Module for Strain Gage and LVDT/RVDT



### Remarks

Validity of all listed specifications are subject to a warm-up period of at least 45 minutes	
Specifications subject to change without notice	

### Mechanical information

Material	Aluminum
Measurements (W x H x D)	30 x 128 x 118 mm
Weight	approx. 100 g

### Ordering Information

Article number	111318
Accessories	Terminal B4/120-A106, article number 894387
	Terminal B4/350-A106, article number 894488

#### Gantner Instruments

Austria | Germany | France | Sweden | India | USA | China | Singapore Montafonerstraße 4 · A-6780 Schruns · T +43 55 56 · 77 463-0 office@gantner-instruments.com www.gantner-instruments.com